, OE					4299-115.1 US 10/731,319						
]	INFO	RMATION DISCLOSURE	CITATION		Applicant(s) SHEFER et al.						
		Ose several sheets if necessar			Filing Date		Group Art Unit				
/ MAR DE					December 8, 2003 (1616-16)						
		SHEW TO THE COUNTY	U	J.S. PATENT	T DOCUMENTS						
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	FILING I			
		•		+	•						
			 								
		·		 							
			U.S. PATE	NT APPLIC	CATION PUBLICATION	4S					
*EXAMINER INITIAL	REF DOCUMENT NUMBER		DATE		NAME	CLASS	SUBCLASS	FILING DATE			
							7107				
			 								
				 							
			 								
			FOR	EIGN PAT	ENT DOCUMENTS						
,	REF	DOCUMENT NUMBER	DATE		COUNTRY		SUBCLASS	Trans YES	lation NO		
and		0 908 174	04/1999 EP								
<i></i>											
			 	 				 			
					<u>.</u>						
	<u></u>	<u> </u>		R DOCUME	•		, Pertinent Pages, E				
		Meylan et al.; Atom/Fra 84(1):83-92 (1995).	agment Contrib	oution Met	hod for Estimating Oc	tanol-Water Par	tition Coefficient	s, J Phar Sc	i		
90	-										
-											
EXAMINE	R	Sull			DATE CONSIDERE	3/	31/07				
		ial if citation considered, whether iclude copy of this form with next				609; Draw line th	rough citation if no	t in conform	ance and		

Form PTO-A820 (also form PTO-1449) P09A/REV05

Patent and Trademark Office * U.S. DEPARTMENT OF COMMERCE

							Application Number			
OIPE					4299-115.1 US		10/731,319			
information disclosure citation					Applicant(s)					
(Use several sheets if necessary)					Shefer, et al.					
APR 0 6 2005					Sheler, et al. Filing Date		Group Art Unit			
•	× × × × × × × × × × × × × × × × × × ×			December 8, 2003			ત	616 [6 [7 1	
		·	TRADEMAN	ATENT	DOCUMENTS					
•EXAMINER	REF	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	PILING		
INITIAL				 					PRIATE	
SO		5,246,603 A	09/21/1993	Tsaur,	et al.					
		4,134,838 A	01/16/1979	Hooper, et al.						
		5,723,420 A	04-16/1996	Holzner, et al.					- :	
							,			
U.S. PATENT APPLICATION PUBLICATIONS										
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME		CLASS SUBCLASS		FILING DATE		
									, AU, C	
-		•								
							-			
	<u></u>		FORE	I IGN PATE	NT DOCUMENTS	<u> </u>		l		
	REF DOCUMENT NUMBER DATE				COUNTRY	CLASS	SUBCLASS	Trans	lation	
/								YES	NO	
991		EP 0266796 A1	11/05/1988	EP						
22									. 1	
			•		1.0					
			OTHER I	OCUMEN	TS (Including Author,	Title, Date,	Pertinent Pages, E	ic.)		
				-		71				
· · · · · · · · · · · · · · · · · · ·										
EXAMINE	R				DATE CONSIDERED	a/1.	100			
		7011	*			7/21	107			
		al if citation considered, whether clude copy of this form with next			nce with MPEP Section 609; D	raw line thro	ough citation if no	t in conform	ance and	

Form PTO-A820 (also form PTO-1449)

P09A/REV05

Patent and Trademark Office * U.S. DEPARTMENT OF COMMERCE

1	,				Docket Number (Optional)		Application Numbe		
INFORMATION DISCLOSURE CITATION					4686-125US Applicant(s)		10/731,319		
(Use several sheets if necessary)					SHEFER et al. Filing Date Group Art Unit				
	0, [December 8, 20		1616 6 7		
MAY 0 3	300K	\$		U.S. PAT	ENT DOCUMENTS				
XAMINER THE	E. S.	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS		G DATE OPRIATE
90		3,971,852	7/27/1976	BRENN	ER et al.	426	103		
		4,339,356	07/13/1982	WHYTI	E	512	4		
		4,803,195	02/07/1989	HOLZN	IER	512	4		
		5,051,222	09/24/1991	MARTE	EN et al.	264	143		
		5,069,231	12/03/1991	RUTHE	RFORD	131	335		
		5,417,153	05/23/1995	KING et al.		99	517		
		5,500,137	03/19/1996	BACON et al.		510	102		
		5,500,138	03/19/1996 BACO		et al.	510	102		
		5,500,154	03/19/1996	BACON et al.		510	102		
		5,508,259	04/16/1996	HOLZN	ER et al.	512	4		4
7		5,525,367 06/11/1996		KING et al. 42		426	533		
······································	· · · · ·			FOREIGN	PATENT DOCUMENTS				
	REF	DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	Trans	NO NO
								 	
				_					
				OTHER D	OCUMENTS (Including A	uthor, Title, D	ate, Pertinent Pa	ges, Etc.)	
0000		Stanton D et al., "Compu Sci, 1992, 32, pp. 306-316	ter-Assisted Pred	diction of l	Normal Boiling Points of P	yrans and P	yrroles", J. Cho	em. Inf. Co	mput.
W									
	7	Murugan, R et al., "Pred	icting physical p	roperties fi	rom molecular structure",	Chemtech, .	June 1994, pp. 1	17-23	
<i>↓</i>									
EXAMINEI	R	9500	$\overline{}$		DATE CONSIDERED	3]	31/0	7	
EXAMINEI not consider	R: Initia red. Inc	l if citation considered, whether or	not citation is in c	onformance	e with MPEP Section 609; Dr	aw line throu	gh citation if not	in conform	ance and
						 			